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We Claim:

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1. A method of making a multi-layer circuit assembly comprising the steps of:
- (a) providing a core structure including an inner dielectric element having first and second metal layers on opposite surfaces thereof;
 - (b) forming one or more through vias extending through said metal layers and said inner dielectric element;
 - (c) coating said metal layers and said through vias with a dielectric material to thereby form a coated structure having first and second outer dielectric layers overlying the first and second metal layers respectively and dielectric material lining said through vias;
 - (d) providing outer metal layers over said first and second outer dielectric layers ;
 - (e) metallizing said coated through vias to form metallic via liners connecting said outer metal layers and insulated from said first and second metal layers.
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2. A method as claimed in claim 1 further comprising the step of selectively patterning said outer metal layers to form first signal lines overlying said first metal layer and second signal lines overlying said second metal layer.
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3. A method as claimed in claim 1, wherein said first metal layer includes a ground plane and said second metal layer includes a power plane.

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A method as claimed in claim 1, wherein said first signal lines are substantially perpendicular to said second signal lines.

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5. A method as claimed in claim 1 further comprising the steps of forming blind vias through said outer dielectric layers to expose one or more regions of said first and second metal layers and metallizing said blind vias so that at least some of said signal lines are connected to said first and second metal layers.

6. A method as claimed in claim 5 wherein said steps of metallizing said blind vias and metallizing said through vias are performed simultaneously.

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7. A method as claimed in claim 2, further comprising the step of forming additional signal lines in at least one of said first and second metal layers before the coating step.

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8. A method as claimed in claim 1, wherein each said through via has side walls, said side walls being covered by said dielectric material during the coating step.

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9. B37 A method as claimed in claim 1, wherein the selectively patterning step includes the step of selectively removing portions of the outer metal layers.

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10. A method as claimed in claim 9 wherein the selectively patterning step includes the step of selectively etching the outer metal layers to form said first and second signal lines therein.

11. A method as claimed in claim 5, wherein the step of providing outer metal layers over the first and second outer dielectric layers includes the step of:

depositing a seed layer over said outer dielectric layers including the blind vias and the exposed regions of said first and second metal layers;
plating or sputtering a metal onto said seed layer.

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12. A method as claimed in claim 2 wherein said step of selectively patterning said outer metal layers includes the step of selectively depositing said outer metal layers.
- 10 13. A method as claimed in claim 5, wherein the step of forming said blind vias includes the step of laser drilling said outer dielectric layers.
- 15 14. A method as claimed in claim 13, further comprising the step of plasma etching said blind vias after the laser drilling step to remove any said dielectric material residue remaining in said blind vias.
15. A method as claimed in claim 1, wherein during the coating step said dielectric material is provided having a uniform thickness.
- 20 16. A method as claimed in claim 1, wherein after the coating step said dielectric material has a uniform thickness of approximately 25-75 microns.
- 25 17. A method as claimed in claim 1, wherein after the coating step said through vias remain open.
18. A method as claimed in claim 1, wherein said through vias have a diameter of approximately 175-200 microns before the coating step and approximately 25-150 microns after the coating step.

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19. A method as claimed in claim 1, wherein the coating step includes the step of electrophoretically depositing said dielectric material.
- 5 20. A method as claimed in claim 1, wherein the coating step includes the step of dipping said core structure in said dielectric material.
- 10 21. A method as claimed in claim 1, wherein the coating step includes the step of spin coating said core structure with said dielectric material.
- Sub C6*
- 15 22. A method as claimed in claim 1, wherein the step of forming said through vias includes the steps of etching said first and second metal layers and drilling said inner dielectric element.
23. A method as claimed in claim 1, wherein the step of forming said through vias includes punching said first and second metal layers and said inner dielectric element.
- 20 24. A method as claimed in claim 1, wherein the step of forming said through vias includes the step of plasma etching.
- Sub C7*
25. A method as claimed in claim 1, wherein the step of forming said through vias includes the steps of:
etching said first and second metal layers to provide aligned openings therein;
aligning a laser in one of said aligned openings and drilling said inner dielectric element.

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26. A method as claimed in claim 1, wherein said first and second metal layers are approximately 1-18 microns thick.

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27. A method as claimed in claim 1, wherein said inner dielectric element is approximately 25-50 microns thick.

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28. A method of making a multi-layer circuit assembly comprising the steps of:

(a) providing an inner dielectric element;

(b) providing first and second metal layers having openings therein on opposite surfaces of said inner dielectric element, each said opening in said first metal layer being in substantial alignment with one of said openings in said second metal layer;

(c) coating said inner dielectric element and said first and second metal layers with a dielectric material to thereby form a coated structure having first and second outer dielectric layers overlying the first and second metal layers respectively;

(d) forming one or more through vias extending through said coated structure, each said through via being in substantial alignment with said aligned openings in said first and second metal layers;

(e) providing first and second outer metal layers over said outer dielectric layers;

(f) metallizing said coated through vias to form metallic via liners connecting said outer metal layers and insulated from said first and second metal layers by dielectric material of said coated structure;

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29. A method as claimed in claim 28 further comprising the step of selectively patterning said outer metal layers to form first signal lines

overlying said first metal layer and second signal lines overlying said second metal layer.

30. A method as claimed in claim 28 further comprising the steps
5 of forming blind vias through said outer dielectric layers to expose one or
more regions of said first and second metal layers and metallizing said blind
vias so that at least some of said signal lines are connected to some first and
second metal layers.

10 31. A method as claimed in claim 30, wherein the steps of
metallizing said through vias and metallizing said blind vias are performed
simultaneously.

15 32. A method as claimed in claim 28, wherein said first metal
layer includes a ground plane and said second metal layer includes a power
plane.

20 33. A method as claimed in claim 29, wherein said first signal
lines are substantially perpendicular to said second signal lines.

34. A method as claimed in claim 33, wherein the selectively
patterning step includes the step etching the outer metal layers.